

---

# International Standard



# 534

---

INTERNATIONAL ORGANIZATION FOR STANDARDIZATION • МЕЖДУНАРОДНАЯ ОРГАНИЗАЦИЯ ПО СТАНДАРТИЗАЦИИ • ORGANISATION INTERNATIONALE DE NORMALISATION

---

## Paper and board — Determination of the thickness of single sheets (and method of calculation of the apparent density of board)

*Papier et carton — Détermination de l'épaisseur des feuilles simples (et méthode de calcul de la masse volumique du carton)*

First edition — 1980-10-01

**STANDARD PREVIEW**  
(standards.iteh.ai)

[ISO 534:1980](https://standards.iteh.ai/catalog/standards/sist/d55b1a3-52b8-4ffe-a237-10c541fe4187/iso-534-1980)

<https://standards.iteh.ai/catalog/standards/sist/d55b1a3-52b8-4ffe-a237-10c541fe4187/iso-534-1980>

---

UDC 676.27 : 676.017.25

Ref. No. ISO 534-1980 (E)

Descriptors : paper, paperboards, determination, thickness, bulk density.

## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards institutes (ISO member bodies). The work of developing International Standards is carried out through ISO technical committees. Every member body interested in a subject for which a technical committee has been set up has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work.

Draft International Standards adopted by the technical committees are circulated to the member bodies for approval before their acceptance as International Standards by the ISO Council.

International Standard ISO 534 was developed by Technical Committee ISO/TC 6, Paper, board and pulps, and was circulated to the member bodies in August 1979.

It has been approved by the member bodies of the following countries :

Australia	Germany, F. R.	Romania
Austria	Hungary	South Africa, Rep. of
Belgium	India	Spain
Brazil	Israel	Sweden
Canada	Italy	Switzerland
Chile	Kenya	Turkey
China	Korea, Rep. of	United Kingdom
Czechoslovakia	Netherlands	USA
Egypt, Arab Rep. of	New Zealand	USSR
Finland	Norway	
France	Poland	

No member body expressed disapproval of the document.

This International Standard cancels and replaces ISO Recommendation R 534-1967, of which it constitutes a technical revision.

# Paper and board — Determination of the thickness of single sheets (and method of calculation of the apparent density of board)

## 1 Scope and field of application

This International Standard specifies a method of measuring the thickness of single sheets of paper and board and a method of calculating the apparent density of the board.

The method of measurement is not applicable to corrugated fibreboard, the thickness of which shall be determined by the method specified in ISO 3034.

It should be noted that two alternative pressures are permitted (see table 1); the pressure of  $100 \pm 10$  kPa is preferred.

NOTE — It is stressed that the thickness of single sheets of paper, obtained by the method specified in this International Standard, is not necessarily identical with the bulking thickness of paper, obtained by the method specified in ISO 438, using the same apparatus.

## 2 References

ISO 186, *Paper and board — Sampling for testing*

ISO 187, *Paper and board — Conditioning of samples*.

ISO 438, *Paper — Determination of bulking thickness and apparent density*.

ISO 536, *Paper and board — Determination of grammage*.

ISO 3034, *Corrugated fibreboard — Determination of thickness*.

ISO 5725, *Precision of test methods — Determination of repeatability and reproducibility by interlaboratory tests*.

## 3 Definitions

**3.1 single sheet thickness** : The distance between one surface of a paper or board and the other, determined under an applied static load, using the standard method of test.

**3.2 apparent density** : The mass per unit volume of the board, calculated from its grammage and thickness, and expressed in grams per cubic centimetre.

NOTE — The apparent density of paper is calculated from its bulking thickness, measured by the method specified in ISO 438.

## 4 Principle

**4.1 Measurement of the thickness of a single sheet of paper or board** over a specified area and under a specific static load by means of a high precision micrometer. Expression of results in terms of the thickness of a single sheet.

**4.2 Calculation of the apparent density of board** from a knowledge of its grammage and thickness.

## 5 Apparatus

**5.1 Micrometer**, provided with two plane parallel circular pressure faces, between which the paper or board is placed for measurement.

The pressure exerted between the pressure faces during the thickness measurement shall be as given in table 1. A dead weight shall be used, to ensure that the pressure between the faces is uniform within the limits stated.

Table 1 — Pressure between pressure faces

Pressure, kPa	Status of value
$100 \pm 10$	Preferred
$50 \pm 5$	Alternative

The pressure faces, two in number, shall form an integral part of the micrometer, such that one face is fixed and the second face is capable of movement in a direction perpendicular to the plane of the fixed face.

One face shall be  $16,0 \pm 0,5$  mm in diameter, and the other face shall be of at least that diameter. Thus, a circular region of a test piece, nominally 200 mm<sup>2</sup> in area, is subjected, during the thickness measurement, to the pressure exerted between the faces.

The whole area of the smaller face shall be in contact with the larger face when the micrometer reading is zero.

The performance requirements of the micrometer shall be such that, when calibrated according to the method given in the annex, the micrometer complies with the requirements given in tables 1 and 2 (see also 9.1).

Table 2 — Micrometer performance requirements

Micrometer characteristic	Maximum permitted value
Indication error	$\pm 2,5 \mu\text{m}$ or $\pm 0,5 \%$
Error of parallelism between pressure faces	$5 \mu\text{m}$ or $1 \%$
Repeatability of measurement (as a standard deviation)	$2,5 \mu\text{m}$ or $0,5 \%$

### NOTES

1 The maximum permitted value of a micrometer characteristic is the greater of the two values quoted for it in the table.

2 Where a tolerance is expressed in the form of a percentage, it is based upon the thickness of the test piece undergoing test. Thus, it is possible for a given micrometer to comply with the requirements of the table for some materials, but not for others.

3 For measurements on very thin papers, an instrument with better performance than that specified may be required.

**5.2 Thickness gauges**, corresponding to approximately 10, 30, 50, 70 and 90 % of the full scale reading of the micrometer. Each gauge shall be accurate to 1  $\mu\text{m}$ .

## 6 Sampling

Sample in accordance with ISO 186.

## 7 Conditioning

Condition the sample in accordance with ISO 187.

## 8 Preparation of test pieces

Prepare 20 or more test pieces from specimens taken at random from those selected in accordance with clause 6. Ensure that not more than two test pieces are taken from any one specimen.

Carry out the preparation in the standard atmospheric condition at which the sample was conditioned.

Cut each test piece to dimensions of at least 60 mm  $\times$  60 mm. Ensure, however, that the test piece dimensions are not so large that the micrometer reading is affected by the test piece mass that overhangs the lower pressure face while a measurement is being made. Therefore, do not permit test pieces of board to exceed 100 mm  $\times$  100 mm.

These test piece dimensions are usually satisfactory for making measurements on paper.

## 9 Procedure

### 9.1 Verification and calibration of micrometer

At appropriate intervals of time, calibrate the micrometer and verify its performance using the method given in the annex.

For micrometers in frequent use, determine the indication error and repeatability of measurement daily. Determine the pressure exerted between the pressure faces and their error of parallelism at monthly intervals.

When measurements are to be made on very thin papers, it may be necessary to verify the performance of the micrometer at the temperature at which it is to be used.

### 9.2 Determination

#### 9.2.1 Thickness

Carry out the test in the standard atmospheric condition at which the sample was conditioned.

Place the micrometer on a horizontal vibration-free surface and interpose the test piece between the open pressure faces of the micrometer. Permit the test piece to be held by the pressure faces by very carefully allowing the moveable pressure face to

move steadily and slowly, at a velocity less than 3 mm/s, towards the fixed pressure face so that any punching effect is avoided. Record the micrometer reading as soon as its value becomes steady but before any "bedding-down" of the paper can occur. The value will usually become steady in about 2 to 5 s. Avoid imposing any manual stress on the test piece or micrometer while a reading is being made.

Carry out one measurement on each test piece, the measurement being made at a position at least 20 mm from any side of the test piece.

#### 9.2.2 Apparent density of board

If the apparent density of the board is to be calculated, determine the grammage of the sample by the method specified in ISO 536.

## 10 Expression of results

### 10.1 Thickness

**10.1.1** Calculate the mean value of the readings (not fewer than 20) to obtain the average thickness of a single sheet. Express the result, in micrometres, to three significant figures.

**10.1.2** Record the maximum and minimum values of single sheet thickness.

**10.1.3** Calculate the standard deviation of the single sheet thickness.

**10.1.4** Calculate the precision of the mean at the 95 % confidence level.

### 10.2 Apparent density of board

Calculate the apparent density of board, in grams per cubic centimetre, from the formula

$$\frac{g}{\delta}$$

where

$\delta$  is the single sheet thickness of the board, in micrometers;

$g$  is the grammage of the board, in grams per square metre.

Report the result to two decimal places.

## 11 Precision

### 11.1 Repeatability

Under routine laboratory conditions, repeatability varies from 0,8  $\mu\text{m}$  to 2,2  $\mu\text{m}$  with a mean value of 1,3  $\mu\text{m}$ , or from 1,1 % to 2,6 %, mean value 2,0 %.

The difference between the two single test values found on identical test material by one operator using the same micrometer within a short time interval will exceed the repeatability on average not more than once in 20 instances in the normal and correct operation of the method.

The values quoted above compare with a value of about 1,5  $\mu\text{m}$  calculated according to ISO 5725 from the specified micrometer performance requirements. The difference arises from the inherent variability of the paper.

### 11.2 Reproducibility

Under routine laboratory conditions, reproducibility varies from 4,2  $\mu\text{m}$  to 8,6  $\mu\text{m}$ , with a mean value of 5,9  $\mu\text{m}$ , or from 4,7 % to 10,9 %, mean value 7,9 %.

The difference between two single and independent results found by two operators working in different laboratories on identical test material will exceed the reproducibility on average not more than once in 20 instances in the normal and correct operation of the method.

The values quoted above compare with a value of about 3,2  $\mu\text{m}$ , calculated according to ISO 5725 from the specified micrometer performance requirements. The difference arises from the inherent variability of paper.

## 12 Test report

The test report shall include the following particulars :

- a) reference to this International Standard;
- b) precise identification of the sample;

- c) date and place of testing;
- d) the conditioning atmosphere used;
- e) the pressure exerted between the micrometer pressure faces, if other than  $100 \pm 10$  kPa;
- f) the average thickness of a single sheet of the paper or board, to three significant figures;
- g) the maximum and minimum values of single sheet thickness;
- h) the standard deviation of the single sheet thickness;
- j) the precision of measurement of the single sheet thickness, in terms of its confidence limits at the 95 % probability level;
- k) if required, the apparent density of the board;
- l) the number of test pieces used for the test;
- m) the number of readings taken;
- n) the grammage of the sample, if determined;
- p) any departure from the procedure specified in this International Standard, together with any circumstances or influences that may have affected the results.

iTech STANDARD PREVIEW  
(standards.iteh.ai)

ISO 534:1980

<https://standards.iteh.ai/catalog/standards/sist/df55b1a3-52b8-4ffe-a237-10c541fe4187/iso-534-1980>

## Annex

### Verification of micrometer performance and calibration

#### A.1 General

Verify the performance of the micrometer, using the following tests in the order given.

If the micrometer performance is not within the tolerance appropriate to a particular test (see 5.1), make the necessary correction and recommence the series of tests.

#### A.2 Planarity of pressure faces

Carefully wipe the pressure faces, open them slightly and observe the gap against a bright light. Look along the plane of the faces in two mutually perpendicular directions and verify that the gap is quite even.

#### A.3 Pressure exerted between pressure faces

Any suitable means of verifying the accuracy and uniformity of the pressure exerted between the pressure faces may be used.

#### A.4 Indication error and repeatability of measurement

**A.4.1** With the pressure faces in contact with one another, set the micrometer reading to zero. Do not reset the zero reading during the following procedure.

**A.4.2** Open the gap between the pressure faces, allow it to close again (see 9.2) so that the pressure faces make contact with one another, and note the micrometer reading. Repeat this procedure at least 5 times.

**A.4.3** Take one of the thickness gauges specified in 5.2, open the gap between the pressure faces, interpose the gauge, allow the faces to close upon the gauge (see 9.2), and note the micrometer reading. Repeat this procedure at least 5 times.

**A.4.4** Repeat the procedure described in A.4.3, using, in turn, each of the remaining thickness gauges.

NOTE — The thickness gauges shall be used singly, not in combination.

**A.4.5** Repeat the procedure described in A.4.2.

**A.4.6** For each gauge thickness at which micrometer readings are taken, calculate :

- a) the repeatability of measurement, that is, the standard deviation of the five, or more, readings taken;
- b) the indication error, that is, the difference between the mean of the five, or more, readings taken and the gauge thickness.

#### A.5 Parallelism of pressure faces

**A.5.1** Take one of the thickness gauges specified in 5.2, open the gap between the pressure faces and position the gauge in the gap, as near as possible to one edge of the faces. Allow the pressure faces to close upon the gauge (see 9.2), and note the micrometer reading.

**A.5.2** Open the gap between the pressure faces and position the thickness gauge in the gap, as near as possible to the edge of the faces and diametrically opposite to the edge used in A.5.1. Allow the pressure faces to close upon the gauge (see 9.2), and again note the micrometer reading.

**A.5.3** Repeat the procedure described in A.5.1 and A.5.2, using positions as near as possible to the edge of the pressure faces and on a diameter perpendicular to that passing through the points referred to in A.5.1 and A.5.2.

**A.5.4** Repeat the procedure described in A.5.1, A.5.2 and A.5.3, using, in turn, each of the remaining thickness gauges.

NOTE — The thickness gauges shall be used singly, not in combination.

**A.5.5** For each gauge thickness at which micrometer readings are taken, calculate the error of parallelism from the formula

$$0,5 \sqrt{d_1^2 + d_2^2}$$

where

$d_1$  is the difference between the readings corresponding to opposite ends of a diameter of the pressure faces;

$d_2$  is the difference between the readings corresponding to opposite ends of a diameter of the pressure faces perpendicular to that used to obtain  $d_1$ .

**iTeh STANDARD PREVIEW**  
**(standards.iteh.ai)**

ISO 534:1980

<https://standards.iteh.ai/catalog/standards/sist/df55b1a3-52b8-4ffe-a237-10c541fe4187/iso-534-1980>

**iTeh STANDARD PREVIEW**  
**(standards.iteh.ai)**

ISO 534:1980

<https://standards.iteh.ai/catalog/standards/sist/df55b1a3-52b8-4ffe-a237-10c541fe4187/iso-534-1980>